Se	Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/706,987	TEI ET AL.
Examiner	Art Unit
Helen L. Pezzuto	1713

SEARCHED				
Class	Subclass	Date	Examiner	
526	333		·	
	336	3/17/2006	HP	
Above	updated	9/8/2006	НР	
Above	updated	3/9/2007	HP	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NO (INCLUDING SEARC)
	DATE	EXMR
STIC STN search	2/15/2006	HP
West, Inventors search	3/17/2006	НР
West, inventors search updated	9/8/2006	HP
STIC STN search updated	3/6/2007	НР
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